

<b>Notice of References Cited</b>	Application/Control No. 10/561,771		Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
	Examiner ROBERT XU		Art Unit 1797	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Reid, Gavin E, et al. 'Top down' protein characterization via tandem mass spectrometry, 2002, Journal of Mass Spectrometry, Vol. 36, pages 663-675.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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